Application/Control No. Applicant(s)/Patent Under Reexamination 09/817,801 **NOVAK ET AL.** Notice of References Cited Examiner Art Unit Page 1 of 1 Kyung H Shin 2143 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,248,946 06-2001 Dwek, Norman Scott 84/609 US-6,496,802 12-2002 В van Zoest et al. 705/14 US-6,330,670 12-2001 С England et al. 713/2 D US-Ε US-F US-US-G US-Н US-1 US-J Κ US-US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) W

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